



Femtosecond laser pre-pulse technology for LPP EUV source

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International Workshop on EUV Sources, UCD Dublin, November 3-6, 2014

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FS Laser



Laser	Generator	Tsunami	Spectra Physics					
	Regenerative amplifier	Spitfire	Spectra Physics					
	Autocorrelator	Pulse Scout	Spectra Physics					
Laser parar	neters							
	Wavelength		800 nm					
	Pulse energy		2.3 mJ					
	Duration(FWHM)		50 fs ÷ 80 ps					
	Gaussian beam energy profile							
	Minimum focal spot size at	VHM) 50 um						
	Average power density in	3*10 ¹⁵ W/cm ²						
	PRR		1 kHz					

Droplet

Sn-In eutectic alloy (48%/52% atomic composition)				
Operating temperatu	ıre 140°C			
Size \varnothing	40, 50, 60, 70 um			
Velocity	≈ 2-4 m/s			
Interaction zone	≈ 1 cm from nozzle.			



Why we used In-Sn alloy



Physical quantity				In	Sn	Δ, %
Atomic number				49	50	2
Atomic weight			11	14.82	118.71	3.3
Density (near r.t.), g*cm ³			-	7.31	7.36	0.7
Liquid density (at melting point) , g*cm ³			-	7.02	6.99	0.4
Molar heat capacity, J*mol ⁻¹ *K ⁻¹			2	6.74	27.11	1.1
Atomic radius, pm				142	139	2.1
Surface tension, din*cm ⁻¹				559	554	0.9
Melting point, ^o C			1	56.6	231.9	16
		1	5	5.78	7.33	21
		Ш	-	18.8	14.6	22
		III	Ĩ	28.0	30.7	8.9
		IV		58	46.5	19.8
		V		77	81	3.7
to viscotione motorations		VI	98		103	4.9
ionization potentials		VII		120	126	4.8
		VIII		144	150	4
		IX		178	176	1.1
		Х		204	213	4.2
Physical quantity	Sn (300° C		C)	In–Sn alloy (200° C)		
Surface tension,din/cm	538			534		
Kinematic viscosity, cSt 0.24		0.25				

- Main physical properties of In, Sn and In-Sn alloy are very similar
- Replacement of Sn on In-Sn eutectic alloy allows to use much more reliable experiments because of lower work temperature.
- The alloy may be used as working substance in LPP EUV source. Conversion efficiency of LPP EUV source by using the alloy is about 70% from one by using pure Sn as working substances.



In-Sn eutectic alloy can be used in modeling experiments for Sn droplet in pre-pulse technology of LPP EUV sources.



Synchronization diagram and DG+FS laser setup





Multistage hit technology of laser beam into droplet



1- FS laser, 2- DG, 3- vacuum chamber, 4- driving generator, 5- frequency divider, 6-delay generator, 7- DG controller, 8- diode laser (IL30C, 850nm, 30ns), 9- long distance microscope (K2 DistaMax), 10-CCD camera (Manta MG-145B), 11- Faraday cup, 12- ion spectrograph, 13- pump, 14- tungsten filament, 15- beam formation optics (diffuser+lens), 16- band pass filter (850nm).



Droplet generator operation



DoD type nozzle based on annular piezoelectric actuator (MJ-SF-002 MicroFab Tech)





8 Hz, 10mm from nozzle



Pulse train at 5kHz run, v ≈ 2.5 m/s



Shadow stroboscopic images 60um droplet

- Spatial resolution 3.7 um
- Exposure time (laser pulse duration) 30 ns



Sets of used experimental parameters



Variable parameters :

- Droplets size
- Laser pulse durations
- Laser pulse energy
- Focal spot sizes

Constant parameter:PRR of DG8 HzPRR of FS laser1 kHz

Ø40 um, E_{las}=2.3 mJ

- 1. 50 fs, 50 um
- 2. 200 fs, 50 um
- 3. 400 fs, 50 um
- 4. 800 fs, 50 um
- 5. 1.5 ps, 50 um

Ø **50 um, E_{las}=2.3 mJ** 50 fs, 50 um 400fs, 50 um

\varnothing 60 um, E_{las}=2.3 mJ

- 1. 50 fs, 50 and 100 um
- 2. 100 fs, 50 and 100 um
- 3. 200 fs, 50 and 100 um
- 4. 450 fs, 50 and 100 um
- 5. 800 fs, 50 and 100 um
- 6. 1.5 ps, 50 and 100 um
- 7. 3 ps, 50 and 100 um
- 8. 5.3 ps, 50 and 100 um
- 9. 80 ps, 50 um

Ø 60 um, E_{las}=1.3 mJ 50 fs, 50 and 100 um

Ø **60 um,** E_{las}=**0.4 mJ** 50 fs, 50 um Ø **70 um, E_{las}=2.3 mJ** 50 fs, 50 um

• Delay between FS and diagnostic lasers 0..20 us

• >160 images in each delay



Droplet deformation at τ_{las} = 50 fs



E_{las} =2.3mJ Ø 60 um



 Δt –delay between FS laser and diagnostic diode laser

The images at different delays belong to different droplets, but deformed images are reproduced very well.

Main difference from ns PP: deformed droplets have shape of hollow thin 3D shells!!

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Droplet deformation at τ_{las} = 450 fs

E_{las} =2.3mJ \emptyset 60 um





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Droplet deformation at τ_{las} = 1.5 ps



E_{las} =2.3mJ Ø 60 um



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Droplet deformation at $\tau_{las} \approx 80$ ps





Shell expansion velocity vs pulse duration





There is weak dependence of droplet expansion velocity on pulse duration at more than 1 ps. Dependence velocity on laser power density for ns lasers $V_z \approx l^{2/3}$ is not working in this case !



Variety of deformed shapes (some examples)



 \varnothing 60 um

Changing experimental parameters (size of droplet and focal spot, laser pulse duration, laser energy, delay) we can choose the optimal target shape for LPP EUV source from point of view max CE, min debris and high energy ions.

All shapes have been stable from pulse to pulse



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Ion flux measurements

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Total ion flux





- Total charge of ions flying against laser beam for 70 um droplets is much more than one for 40 um droplet.
- Total charge of ions flying against laser beam is much more than ones flying in along laser beam.
- There is min total charge at 800 fs pulse duration which correlates with max of shell expansion velocities.

Distribution of total ion charge on ion energy





- High-energy ions fly only in the opposite direction to the propagation of the laser beam.
- Maximum number of the high-energy ions observed at 50 fs pulse.
- There is minimum of the high-energy ions at 800 fs pulse.



Ion spectrum measurements



Electrostatic ion energy analyzer based on a cylindrical capacitor



E_{ion} = 1.25*Z*U, U – deflection voltage, 1.25 - energy scaling factor
Detector Faraday cup
Input aperture 1 mm
Azimuth angle between laser beam and IS 30°
Angle in vertical plane to the laser beam 17°
Distance to the droplet 500 mm



Oscillograms of ion beam current

Droplet \varnothing 50 um, focal spot size 50 um



 τ_{laser} = 50 fs, P=1.5*10¹⁵ W/cm² U = 800 V

$$\tau_{\text{laser}}$$
 = 400 fs, P=3.8*10¹⁴ W/cm² U = 200 V

32 measurements averaging.

Ion multiplicity for 50 fs pulse much more than for 400 fs pulse

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Debris deposition



Number of pulses ≈ 25 000

Minimal size of observed debris ≈ 90 nm

Electron microscope photos



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Debris distribution

SOUTH OF SPECTROBODY RUSS

For particles >250nm, step of particle sizes 100nm



 Distribution for all modes and both directions are close.
 Mass of particles flying along laser beam direction are much more than ones flying against laser beam direction

At isotropic scattering of debris masses would be: For 60um 6.6*10⁻⁸ g/sr For 55 um 5*10⁻⁸ g/sr For 40 um 1.9*10⁻⁸ g/sr

Where is difference?

Vapor?

Number and mass of debris from single droplet in 1 sr

	60 um, 50 fs	40 um, 5.3 ps	55 um, 5.3 p s
Sample A	≈ 16 300 (4.9*10 ⁻⁸ g/sr)	≈ 6 400 (2.6*10 ⁻⁸ g/sr)	≈ 2 600 (1.5*10 ⁻⁸ g/sr)
Sample B	≈ 9 400 (10 ⁻⁸ g/sr)	≈ 2 400 (0.2*10 ⁻⁸ g/sr)	≈ 1 600 (0.37*10 ⁻⁸ g/sr)

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Summary



- In-Sn droplet deformation and fragmentation dynamic at the action of femto- and picosecond laser in wide band pulse duration from 50 fs up to 80 ps at power density up to $P=3*10^{15}$ W/cm² were studied by ultrafast shadowgraph method. Changing experimental parameters it is possible choose the optimal shape of target for LPP EUV source.
- Total ion charge and ion spectrum measurements at action of laser with femto- and picosecond pulse duration on In-Sn droplets were carried out. It is established that high-energy ions up to 8 keV are present only in the opposite direction to the laser beam.
- Debris distributions at interaction of femto- and picosecond laser with In-Sn droplets. It is established that particles flying along laser beam are much more than ones flying against laser beam.





Acknowledgements

We thank ASML company for technical support our experiments.

Thank You for Your Attention